



LeCroy Digital Storage Oscilloscope

Performance Certificate

Model	Serial Number	Custom	ner
Software Version_			
Inspection Date	Next Du	ıe	-
Temperature	Humidity%	<u>,</u>	
Tested By	Report Nur	mber	
Place of Inspection			
Condition found	Condition	on Left	
,	Approved By		
Т	est Equipment U	Jsed	
Instrument	Model	S/N	Cal Due Date
Signal Generator_ Radio Frequency			_
Signal Generator_ Audio Frequency			_
Voltage Generator DC Power Supply			_
Step Generator Fast Pulser			-
Digital Multimeter_ Voltmeter, Ohmme	ter	_	-
	Traceable to		

Table 1: LC684D Test Report

Rev. B 1 of 12



Coupling	Volts/div.	Measured Channel 1 Impedance Ω , M Ω	Measured Channel 2 Impedance Ω , M Ω	Measured Channel 3 Impedance Ω , M Ω	Measured Channel 4 Impedance Ω , M Ω	Measured External Impedance Ω, MΩ	Measured External/5 Impedance Ω, MΩ	Lower Limit Ω, ΜΩ	Upper Limit Ω, MΩ
DC 1MΩ	50 mV/div					N/A	N/A	0.99 MΩ	1.01 MΩ
DC 1MΩ	50 mV/div	N/A	N/A	N/A	N/A			0.98 MΩ	1.02 MΩ
DC 1M Ω	200 mV/div					N/A	N/A	$0.99~\mathrm{M}\Omega$	1.01 MΩ
AC 1M Ω	50 mV/div					N/A	N/A	1.006 M Ω	$1.047~\mathrm{M}\Omega$
AC 1MΩ	200 mV/div					N/A	N/A	0.98 MΩ	1.02 MΩ
DC 50 Ω	50 mV/div					N/A	N/A	$49.375~\Omega$	$50.625~\Omega$
DC 50Ω	200 mV/div					N/A	N/A	49.375 Ω	50.625 Ω
DC 50Ω	50 mV/div	N/A	N/A	N/A	N/A			48.5 Ω	51.5 Ω
Grounded	50 mV/div					N/A	N/A	$0.98~\mathrm{M}\Omega$	$1.02~\mathrm{M}\Omega$

Table 2: Impedance Test Record

Coupling	Volts/div.	Measured Channel 1 Leakage mV	Measured Channel 2 Leakage mV	Measured Channel 3 Leakage mV	Measured Channel 4 Leakage mV	Measured External Leakage mV	Lower Limit mV	Upper Limit mV
DC 1M Ω	50 mV/div					N/A	-1	+1
DC 1M Ω	200 mV/div					N/A	-1	+1
DC 50Ω	50 mV/div					N/A	-1	+1
DC 50Ω	200 mV/div					N/A	-1	+1
DC 50 Ω	50 mV/div	N/A	N/A	N/A	N/A		-1	+1
DC 1M Ω	50 mV/div	N/A	N/A	N/A	N/A		-2	+2

Table 3: Leakage Voltage Test Record

Rev. B 2 of 12



Coupling	Time/Div.	Measured Pkpk Channel 1 mV	Measured Pkpk Channel 2 mV	Measured Pkpk Channel 3 mV	Measured Pkpk Channel 4 mV	Limits mV
DC 1MΩ	20 ms					7.2
DC 1MΩ	1 ms					7.2
AC 1MΩ	2 μs					7.2
DC 50Ω	2 μs					7.2
DC 50Ω	20 μs					7.2
DC 50Ω : 2 Channel Mode	1 μs	disabled			disabled	7.2
DC 50Ω : 1 Channel Mode	0.5 μs	disabled	* see note	disabled	disabled	7.2

Table 4: Peak to Peak Noise Test Record

Coupling	Time/Div.	Measured sdev Channel 1	Measured sdev Channel 2	Measured sdev Channel 3	Measured sdev Channel 4	Limits
		mV	mV	mV	mV	mV
DC 1MΩ	20 ms					0.72
DC 1MΩ	1 ms					0.72
AC 1MΩ	2 μs					0.72
DC 50Ω	2 μs					0.72
DC 50Ω	20 μs					0.72
DC 50Ω: 2 Channel Mode	1 μs	disabled			disabled	0.72
DC 50Ω: 1 Channel Mode	0.5 μs	disabled	* see note	disabled	disabled	0.72

Table 5: RMS Noise Test Record

• Note: Divide measured value by 2, due to PP096 channel combining



Coupling	Volts/div.	Measured Channel 1 Mean (A) mV	Measured Channel 2 Mean (B) mV	Measured Channel 3 Mean (C) mV	Measured Channel 4 Mean (D) mV	Lower Limit mV	Upper Limit mV
DC 1M Ω	2 mV					-0.8	+0.8
DC 1M Ω	5 mV					-2	+2
DC 1M Ω	10 mV					-1.6	+1.6
DC 1M Ω	20 mV					-3.2	+3.2
DC 1M Ω	50 mV					-8	+8
DC 1M Ω	.1 V					-16	+16
DC 1M Ω	1 V					-160	+160

Table 6: DC 1MΩ Ground Line Test Record

Coupling	Volts/div.	Measured Channel 1 Mean (A) mV	Measured Channel 2 Mean (B) mV	Measured Channel 3 Mean (C) mV	Measured Channel 4 Mean (D) mV	Lower Limit mV	Upper Limit mV
DC 50Ω	2 mV					-0.8	+0.8
DC 50Ω	5 mV					-2	+2
DC 50Ω	10 mV					-1.6	+1.6
DC 50Ω	20 mV					-3.2	+3.2
DC 50Ω	50 mV					-8	+8
DC 50Ω	.1 V					-16	+16
DC 50Ω	1 V					-160	+160
DC 50Ω: 2 Channel Mode	.2 V	disabled			disabled	-48	+48
DC 50Ω: 1 Channel Mode	.2 V	disabled	* see note	disabled	disabled	-64	+64

Table 7: DC 50Ω Ground Line Test Record

• Note: Divide measured value by 2, due to PP096 channel combining



Erroneous Read / Write Test is no longer required.

Volts /div.	Attenuator	P S Output	Meas	ured Cha V & mV		Meas	ured Cha V & mV		Meas	ured Ch V & m\		Meas	sured Ch V & r		Limits
			DMM 1	Mean (A)	Δ1 Mean– DMM	DMM 2	Mean (B)	Δ2 Mean– DMM	DMM 3	Mean (C)	∆ 3 Mean– DMM	DMM 4	Mean (D)	Δ4 Mean– DMM	mV
2 mV	X 100	+0.6 V													±0.8
5 mV	X 100	+1.5 V													±1.2
10 mV	X 100	+3.0 V													±1.6
20 mV	X 100	+6.0 V													±3.2
50 mV	X 10	+1.5V												±8	
.1 V	X 10	+3.0 V											±16		
1 V	X 1	+3.0 V													

Table 9: DC 50Ω , Positive DC Accuracy Test Record

Rev. B 5 of 12



Volts /div.	Attenuator	P S Output	Meas	Measured Channel 1 V & mV DMM Mean Δ 1 Mean— DMM			ured Cha V & mV		Meas	ured Cha V & m		Meas	ured Cha V & n		Limits
			DMM 1		Mean-	DMM 2	Mean (B)	Δ2 Mean– DMM	DMM 3	Mean (C)	Δ3 Mean- DMM	DMM 4	Mean (D)	Δ4 Mean– DMM	mV
5 mV	X 100	+1.5 V													±1.2
.1 V	X 10	+3.0 V													±16
5 V	X 1	+15.0 V													±800

Table 10: DC 1M Ω , Positive DC Accuracy Test Record

Volts /div.	Attenuator	P S Output	Meas	ured Cha V & mV		Meas	sured Cha V & m		Meas	ured Ch V & m		Meas	sured Ch V & n		Limits
			DMM 1	Mean (A)	∆ 1 Mean– DMM	DMM 2	Mean (B)	Δ2 Mean- DMM	DMM 3	Mean (C)	Δ3 Mean– DMM	DMM 4	Mean (D)	Δ4 Mean– DMM	mV
2 mV	X 100	- 0.6 V													±0.8
5 mV	X 100	-1.5 V													±1.2
10 mV	X 100	-3.0 V													±1.6
20 mV	X 100	-6.0 V													±3.2
50 mV	X 10	-1.5V													±8
.1 V	X 10	-3.0 V													±16
1 V	X 1	-3.0 V													±160

Table 11: DC 50Ω , Negative DC Accuracy Test Record

Rev. B 6 of 12



Volts /div.	Attenuator	P S Output	Meas	Measured Channel 1 V & mV DMM Mean 1 (A) Mean— DMM			ured Cha V & m\		Meas	ured Cha V & m		Meas	ured Cha V & m		Limits
			DMM 1	1 (A) Mean-			DMM Mean Δ 2 2 (B) Mean-DMM			Mean (C)	∆3 Mean– DMM	DMM 4	Mean (D)	∆ 4 Mean– DMM	mV
5 mV	X 100	-1.5 V													±1.2
.1 V	X 10	-3.0 V													±16
5 V	X 1	-15.0 V													±800

Table 12: DC 1M Ω , Negative DC Accuracy Test Record

Volt /div.	Coupling DC	DSO offset	P S output	Meas	1 (A) Mean-			ured Cha V & mV		Meas	ured Cha V & mV		Meas	ured Cha V & mV		Limits
			,	DMM 1			DMM 2	Mean (B)	Δ2 Mean– DMM	DMM 3	Mean (C)	Δ3 Mean- DMM	DMM 4	Mean (D)	Δ4 Mean– DMM	mV
2mV	50 Ω	+0.4 V	-0.4 V													±4.8
5mV	50 Ω	+1 V	-1 V													±11.2
5mV	1 ΜΩ	+1 V	-1 V								•			•		±11.2

Table 13: Positive Offset Test Record

Rev. B 7 of 12



Volt /div.	Coupling DC	DSO offset	P S output	Meas	Measured Channel 1 V & mV			Measured Channel 2 V & mV			Measured Channel 3 V & mV			Measured Channel 4 V & mV		
				DMM 1	Mean (A)	Δ1 Mean– DMM	DMM 2	Mean (B)	Δ2 Mean– DMM	DMM 3	Mean (C)	Δ3 Mean- DMM	DMM 4	Mean (D)	Δ4 Mean– DMM	mV
2mV	50 Ω	-0.4 V	+0.4 V													±4.8
5mV	50 Ω	-1 V	+1 V													±11.2
5mV	1 MΩ	-1 V	+1 V													±11.2

Table 14: Negative Offset Test Record

Frequency	Measured Power	Generator Amplitude		sured inel 1		sured inel 2		sured inel 3	Measured Channel 4		Lower Limit	Upper Limit
MHz	mW	mV	Sdev(1) mV	Ratio(1) to 0.3	Sdev(2) mV	Ratio(2) to 0.3	Sdev(3) mV	Ratio(3) to 0.3	Sdev(4) mV	Ratio(4) to 0.3		
0.300	0.200			N/A		N/A		N/A		N/A	N/A	N/A
1.1	0.200										0.9	1.1
30.1	0.200										0.9	1.1
300.1	0.200										0.87	1.13
700.1	0.200										0.81	1.19
1000.1	0.200										0.70	1.34
1500.1	0.200										0.70	N/A

Table 15: DC 50 Ω , 50 mV/div. Bandwidth Test Record

Rev. B 8 of 12



Frequency	Measured Power	Generator Amplitude		sured nnel 1		sured inel 2		sured inel 3		Measured Channel 4		Upper Limit
MHz	mW	mV	Sdev(1) mV	Ratio(1) to 0.3	Sdev(2) mV	Ratio(2) to 0.3	Sdev(3) mV	Ratio(3) to 0.3	Sdev(4) mV	Ratio(4) to 0.3		
0.300	0.800			N/A		N/A		N/A		N/A	N/A	N/A
1.1	0.800										0.9	1.1
30.1	0.800										0.9	1.1
300.1	0.800										0.87	1.13
700.1	0.800										0.81	1.19
1000.1	0.800										0.70	1.34
1500.1	0.800										0.70	N/A

Table 16: DC 50Ω , 100 mV/div. Bandwidth Test Record

Global BWL	Amplitude at 300 kHz	Meas Chan		Measured Channel 2		Measured Channel 3		Measured Channel 4		Lower Limit	Upper Limit
MHz	Sdev mV	Sdev(1) mV	Freq(1) MHz	Sdev(2) mV	Freq(2) MHz	Sdev(3) mV	Freq(3) MHz	Sdev(4) mV	Freq(4) MHz	MHz	MHz
25	200	140		140		140		140		10	37
200	200	140		140		140		140		110	290

Table 17: DC 50 Ω , Bandwidth Limiter Test Record

Rev. B 9 of 12



Frequency	Measured Channel 1		Measured Channel 2		Measured Channel 3		Measured Channel 4		Lower Limit
MHz	Sdev(1) mV	Ratio(1) to 0.3	Sdev(2) mV	Ratio(2) to 0.3	Sdev(3) mV	Ratio(3) to 0.3	Sdev(4) mV	Ratio(4) to 0.3	
0.300	200	N/A	200	N/A	200	N/A	200	N/A	N/A
500.1									0.7

The 1 Meg. Ohm BW test may be omitted if the proper 4962-10 is not available. An adjusted passive probe may be substituted.

Table 18: DC 1M Ω , 100 mV/div. Bandwidth Test Record

Trigger Level	Trigger Slope	Channel 1	Channel 2	Channel 3	Channel 4	Lower Limit	Upper Limit
		Measured DC Trigger Level (1)	Measured DC Trigger Level (2)	Measured DC Trigger Level (3)	Measured DC Trigger Level (4)		
mV		mV	mV	mV	mV	mV	mV
0	Pos					-30	+30
0	Neg					-30	+ 30
+300	Pos					+250	+350
+300	Neg					+250	+350
-300	Pos					-250	-350
-300	Neg					-250	-350

Table 19: Channel DC Trigger Test Record

Rev. B 10 of 12



This table has beed omitted, the HFREJ test is no longer required

Table 20: Channel HFREJ Trigger Test Record

Trigger Slope	External Trigger Level	External DC	External HFREJ	Exte Lin	ernal nits	External/5 Trigger Level	External/5 DC	External/5 HFREJ		rnal/5 nits
		Measured DC Trigger Level (Ext)	Measured HFREJ Trigger Level (Ext)	Lower	Upper		Measured DC Trigger Level (Ext5)	Measured HFREJ Trigger Level (Ext5)	Lower	Upper
	mV	mV	mV	m۷	m۷	V	V	V	V	V
Pos	0			-50	+50	0			-0.25	+0.25
Neg	0			-50	+50	0			-0.25	+0.25
Pos	+300			+245	+355	+3			+1.7	+4.3
Neg	+300			+245	+355	+3			+1.7	+4.3
Pos	-300			-245	-355	-3			-1.7	-4.3
Neg	-300			-245	-355	-3			-1.7	-4.3

Table 21: External & Ext/5 DC Trigger Test Record The HFREJ test is no longer required

Rev. B 11 of 12



Smart Trigger Pulse Width	Generator Frequency	Width	Width	Triggered	Pass
ns	MHz	<	>		
< 10	100	On	Off	Yes	
< 10	100	Off	On	No	
> 10	40	Off	On	Yes	
> 10	40	On	Off	No	
< 100	10	On	Off	Yes	
< 100	10	Off	On	No	
> 100	4	Off	On	Yes	
> 100	4	On	Off	No	

Table 22: Smart Trigger Test Record

Generator Frequency	Post Trigger Delay	Delay (A)	Delay (1)	Difference delay(A) –delay(1)+5msec	Lower Limit	Upper Limit
MHz 1.00000	5.00000	ns	msec		μ sec -0.5	μ sec +0.5

Table 23: Time Base Test Record

Rise time and Overshoot Test is no longer required.

Rev. B 12 of 12